MOSFET - Power, Single P-Channel, SO8-FL

-30 V, 2.7 mΩ, -164 A

NTMFS005P03P8Z

Features

- Ultra Low R_{DS(on)} to Improve System Efficiency
- Advanced Package Technology in 5x6mm for Space Saving and Excellent Thermal Conduction
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Load Switch
- Protection: Reverse Current, Over Voltage, and Reverse Negative Voltage
- Battery Management

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit | | |
|---|--|-----------------------|-----------------------------------|----------------|------|--|--|
| Drain-to-Source Voltage | | | V _{DSS} | -30 | V | | |
| Gate-to-Source Voltage | | | V _{GS} | ±25 | V | | |
| Continuous Drain | | $T_{C} = 25^{\circ}C$ | ۱ _D | -164 | А | | |
| Current $R_{\theta JC}$ (Note 3) | Steady | $T_C = 85^{\circ}C$ | | -118 | | | |
| Power Dissipation $R_{\theta JC}$ (Note 3) | State | T _C = 25°C | P _D | 104 | W | | |
| Continuous Drain Cur- | | T _A = 25°C | Ι _D | -28.6 | А | | |
| rent $R_{\theta JA}$ (Notes 1, 3) | Steady | $T_A = 85^{\circ}C$ | | -20.6 | | | |
| Power Dissipation $R_{\theta JA}$ (Notes 1, 3) | State | T _A = 25°C | PD | 3.2 | W | | |
| Continuous Drain Cur- | Steady | $T_A = 25^{\circ}C$ | I _D | -15.3 | А | | |
| rent $R_{\theta JA}$ (Notes 2, 3) | | T _A = 85°C | 1 | -11 | | | |
| Power Dissipation $R_{\theta JA}$ (Notes 2, 3) | State | $T_A = 25^{\circ}C$ | PD | 0.9 | W | | |
| Pulsed Drain Current | Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \ \mu s$ | | | -597 | А | | |
| Single Pulse Drain-to-Source Avalanche Energy (I _{Lpk} = 57.59 A) | | | E _{AS} | 165.8 | mJ | | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +150 | °C | | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | ΤL | 260 | °C | | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

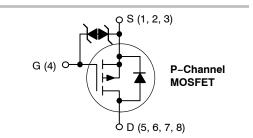
- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using a minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

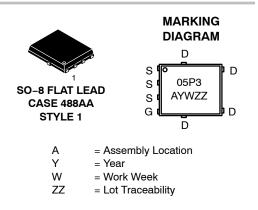


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| V _{(BR)DSS} | R _{DS(on)} | ID |
|----------------------|------------------------|--------|
| -30 V | 2.7 m Ω @ –10 V | –164 A |
| -30 v | 4.4 mΩ @ -4.5 V | -104 A |





ORDERING INFORMATION

| Device | Package | Shipping [†] | | |
|-------------------|-----------|-----------------------|--|--|
| NTMFS005P03P8ZT1G | SO8-FL | 1500 / Tape & | | |
| | (Pb-Free) | Reel | | |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|--|-----------------------|-------|------|
| Junction-to-Case - Steady State (Drain) (Note 1) | $R_{	extsf{	heta}JC}$ | 1.2 | °C/W |
| Junction-to-Ambient - Steady State (Note 1) | R_{\thetaJA} | 40 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | R_{\thetaJA} | 137 | °C/W |

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

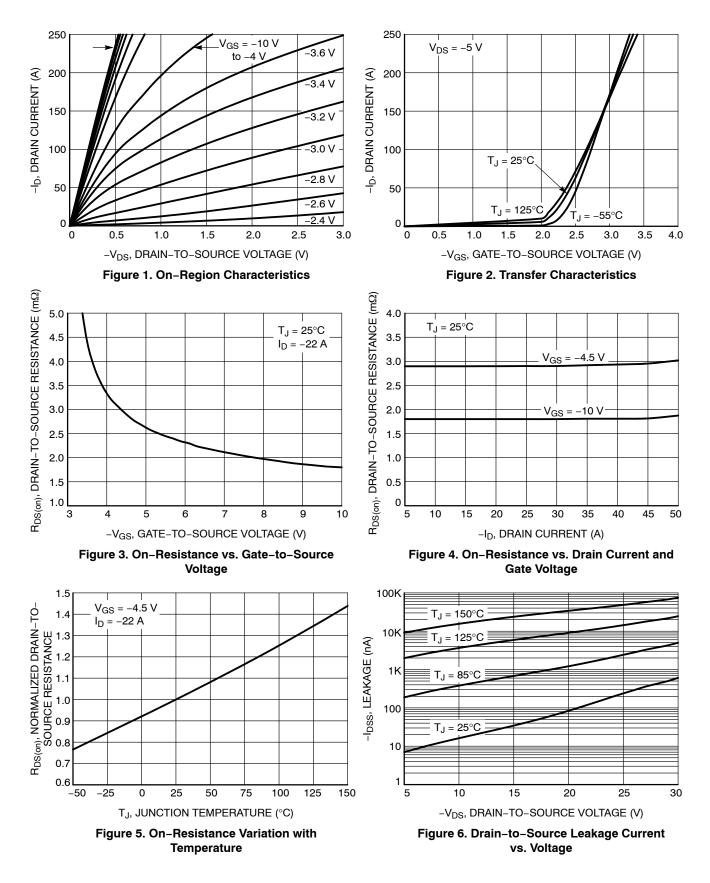
| Parameter | Symbol | Test Condition | | Min | Тур | Мах | Unit |
|--|--|---|-----------------------|------|-------|---------|-------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I_D = -250 μ A | | -30 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / T _J | $I_D = -250 \ \mu\text{A}$, ref to 25°C | | | -8.3 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, V _{DS} = -24 V | T _J = 25°C | | | -1.0 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} | ₃ = ±25 V | | 1 | ±10 | μΑ |
| ON CHARACTERISTICS (Note 4) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = –250 μA | -1.0 | | -3.0 | V |
| Threshold Temperature Coefficient | V _{GS(TH)} /T _J | I _D = –250 μA, r | ef to 25°C | | 5.3 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = -10 V, I _[| ₀ = -22 A | | 1.8 | 2.7 | mΩ |
| | | V _{GS} = -4.5 V, I | _D = -16 A | | 2.9 | 4.4 | |
| Froward Transconductance | 9 _{FS} | $V_{DS} = -5$ V, I_{D} | = -16 A | | 87 | | S |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, V _{DS} = -15 V, f = 1.0 MHz | | | 7880 | | pF |
| Output Capacitance | C _{oss} | | | | 2630 | | |
| Reverse Transfer Capacitance | C _{rss} | | | | 2550 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -22 \text{ A}$ | | | 112 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 8 | |] |
| Gate-to-Source Charge | Q _{GS} | | | | 16 | | |
| Gate-to-Drain Charge | Q _{GD} | | | | 76 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -10 \text{ V}, \text{ V}_{DS} = -15 \text{ V},$ $I_D = -22 \text{ A}$ | | | 183 | | |
| SWITCHING CHARACTERISTICS, VG | s = 4.5 V (Note | 4) | | | | | |
| Turn–On Delay Time | t _{d(on)} | | | | 56 | | ns |
| Rise Time | t _r | V _{GS} = -4.5 V, V _D | e = −15 V. | | 308 | | |
| Turn-Off Delay Time | t _{d(off)} | $I_{\rm D} = -22$ A, R | $_{\rm G} = 6 \Omega$ | | 124 | | 1 |
| Fall Time | t _f | | | | 269 | | 1 |
| SWITCHING CHARACTERISTICS, Vo | as = 10 V (Note 4 | 4) | | | • | | - |
| Turn-On Delay Time | t _{d(on)} | V _{GS} = -10 V, V _{DS} = -15 V, I _D = -22 A, R _G = 6 Ω | | | 22 | | ns |
| Rise Time | t _r | | | | 79 | | |
| Turn-Off Delay Time | t _{d(off)} | | | | 220 | | |
| Fall Time | t _f | | | | 258 | | 1 |
| DRAIN-SOURCE DIODE CHARACTE | RISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | $V_{GS} = 0 V,$ | $T_J = 25^{\circ}C$ | | -0.77 | -1.3 | V |
| | | $I_{\rm S} = -22 {\rm A}$ $T_{\rm J} = 125^{\circ}{\rm C}$ | | | -0.63 | | 1 |

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

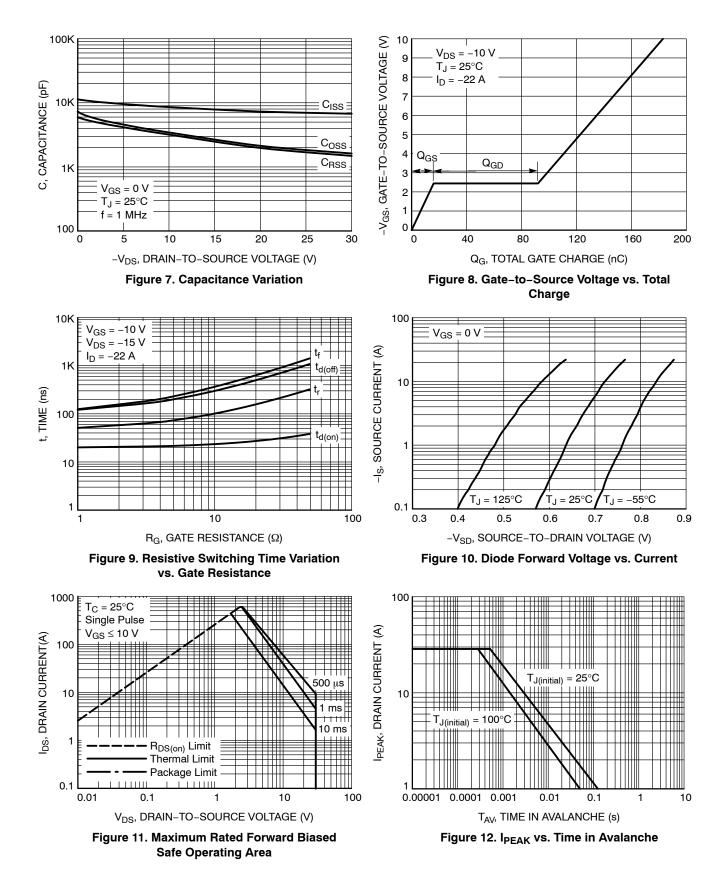
| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit | |
|------------------------------------|-----------------|---|-----|-----|-----|------|--|
| DRAIN-SOURCE DIODE CHARACTERISTICS | | | | | | | |
| Reverse Recovery Time | t _{RR} | | | 57 | | ns | |
| Charge Time | ta | V_{GS} = 0 V, dI_s/dt = 100 A/µs, I_s = -22 A | | 34 | | | |
| Discharge Time | t _b | | | 23 | | | |
| Reverse Recovery Charge | Q _{RR} | | | 77 | | nC | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

TYPICAL CHARACTERISTICS



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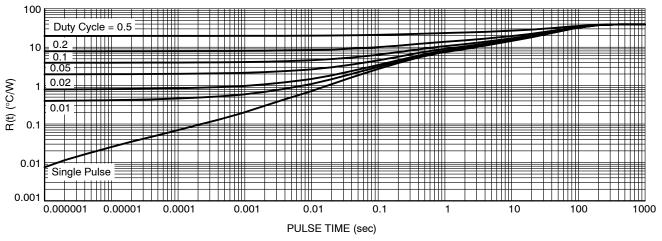
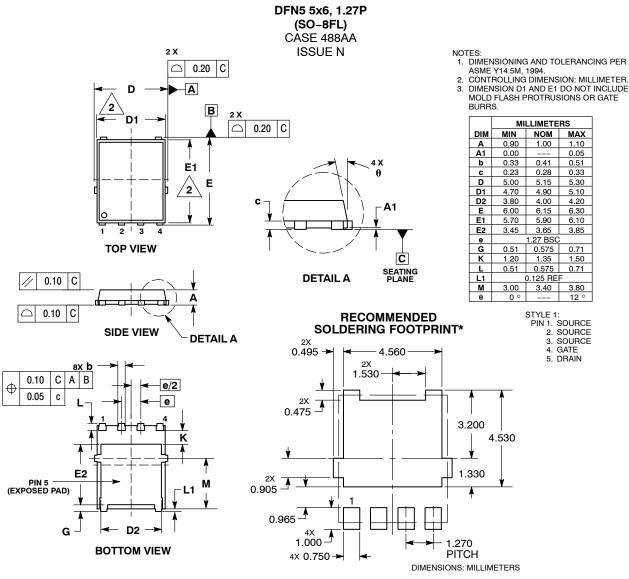


Figure 13. Thermal Characteristics

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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